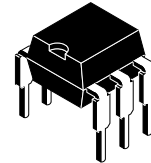


## Optocoupler with Phototransistor Output

### Description

The 4N35/ 4N36/ 4N37 consist of a phototransistor optically coupled to a gallium arsenide infrared-emitting diode in a 6-lead plastic dual inline package. The elements are mounted on one leadframe using a **coplanar technique**, providing a fixed distance between input and output for highest safety requirements.



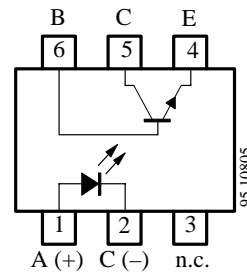
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### Applications

Galvanically separated circuits for general purposes

### Features

- Isolation test voltage (RMS) 3.75 kV
- Underwriters Laboratory (UL) 1577 recognized, file number E-76222
- Low coupling capacity of typical 0.3 pF
- **C**urrent **T**ransfer **R**atio (CTR) > 100%
- Low temperature coefficient of CTR



### Order Instruction

Ordering Code	CTR Ranking	Remarks
4N35	> 100%	
4N36	> 100%	
4N37	> 100%	



## Absolute Maximum Ratings

### Input (Emitter)

Parameter	Test Conditions	Symbol	Value	Unit
Reverse voltage		$V_R$	6	V
Forward current		$I_F$	60	mA
Forward surge current	$t_p \leq \mu s$	$I_{FSM}$	3	A
Power dissipation	$T_{amb} \leq 25^\circ C$	$P_V$	100	mW
Junction temperature		$T_j$	125	$^\circ C$

### Output (Detector)

Parameter	Test Conditions	Symbol	Value	Unit
Collector base voltage		$V_{CBO}$	70	V
Collector emitter voltage		$V_{CEO}$	30	V
Emitter collector voltage		$V_{ECO}$	7	V
Collector current		$I_C$	50	mA
Peak collector current	$t_p/T = 0.5, t_p \leq 10 \text{ ms}$	$I_{CM}$	100	mA
Power dissipation	$T_{amb} \leq 25^\circ C$	$P_V$	150	mW
Junction temperature		$T_j$	125	$^\circ C$

### Coupler

Parameter	Test Conditions	Symbol	Value	Unit
Isolation test voltage (RMS)	$t = 1 \text{ min}$	$V_{IO}^{1)}$	3.75	kV
Total power dissipation	$T_{amb} \leq 25^\circ C$	$P_{tot}$	250	mW
Ambient temperature range		$T_{amb}$	-55 to +100	$^\circ C$
Storage temperature range		$T_{stg}$	-55 to +125	$^\circ C$
Soldering temperature	2 mm from case, $t \leq 10 \text{ s}$	$T_{sd}$	260	$^\circ C$

<sup>1)</sup> Related to standard climate 23/50 DIN 50014


**Electrical Characteristics** ( $T_{amb} = 25^{\circ}\text{C}$ )

**Input (Emitter)**

Parameter	Test Conditions	Symbol	Min.	Typ.	Max.	Unit
Forward voltage	$I_F = 10\text{ mA}$	$V_F$		1.2	1.5	V
Forward voltage	$I_F = 10\text{ mA}$ , $T_{amb} = 100^{\circ}\text{C}$	$V_F$			1.4	V
Junction capacitance	$V_R = 0$ , $f = 1\text{ MHz}$	$C_j$		50		pF

**Output (Detector)**

Parameter	Test Conditions	Symbol	Min.	Typ.	Max.	Unit
Collector base voltage	$I_C = 100\text{ }\mu\text{A}$	$V_{CBO}$	70			V
Collector emitter voltage	$I_C = 1\text{ mA}$	$V_{CEO}$	30			V
Emitter collector voltage	$I_E = 100\text{ }\mu\text{A}$	$V_{ECO}$	7			V
Collector dark current	$I_F = 0$ , $E = 0$ , $V_{CE} = 10\text{ V}$	$I_{CEO}$		5	50	nA
	$I_F = 0$ , $E = 0$ , $V_{CE} = 30\text{ V}$ , $T_{amb} = 100^{\circ}\text{C}$	$I_{CEO}$			500	$\mu\text{A}$

**Coupler**

Parameter	Test Conditions	Symbol	Min.	Typ.	Max.	Unit
Isolation test voltage (RMS)	$f = 50\text{ Hz}$ , $t = 2\text{ s}$	$V_{IO}^{1)}$	3.75			kV
Isolation resistance	$V_{IO} = 1\text{ kV}$ , 40% relative humidity	$R_{IO}^{1)}$		$10^{12}$		$\Omega$
Collector emitter saturation voltage	$I_F = 10\text{ mA}$ , $I_C = 0.5\text{ mA}$	$V_{CEsat}$			0.3	V
Cut-off frequency	$I_F = 10\text{ mA}$ , $V_{CE} = 5\text{ V}$ , $R_L = 100\text{ }\Omega$	$f_c$		110		kHz
Coupling capacitance	$f = 1\text{ MHz}$	$C_k$		0.3		pF

<sup>1)</sup> Related to standard climate 23/50 DIN 50014

**Current Transfer Ratio (CTR)**

Parameter	Test Conditions	Type	Symbol	Min.	Typ.	Max.	Unit
$I_C/I_F$	$V_{CE} = 10\text{ V}$ , $I_F = 10\text{ mA}$	4N35, 4N36, 4N37	CTR	1			
	$V_{CE} = 10\text{ V}$ , $I_F = 10\text{ mA}$ , $T_{amb} = 100^{\circ}\text{C}$	4N35, 4N36, 4N37	CTR	0.4			



### Switching Characteristics

Parameter	Test Conditions	Symbol	Typ.	Unit
Turn-on time (typical)	$V_S = 10\text{ V}$ , $I_C = 2\text{ mA}$ , $R_L = 100\ \Omega$ (see figure 1)	$t_{on}$	5.5	$\mu\text{s}$
Turn-on time (maximum)		$t_{on}$	10.0	$\mu\text{s}$
Turn-off time (typical)		$t_{off}$	4.5	$\mu\text{s}$
Turn-off time (maximum)		$t_{off}$	10.0	$\mu\text{s}$
Turn-on time	$V_S = 5\text{ V}$ , $I_F = 10\text{ mA}$ , $R_L = 1\text{ k}\Omega$ (see figure 2)	$t_{on}$	9.0	$\mu\text{s}$
Turn-off time		$t_{off}$	18.0	$\mu\text{s}$

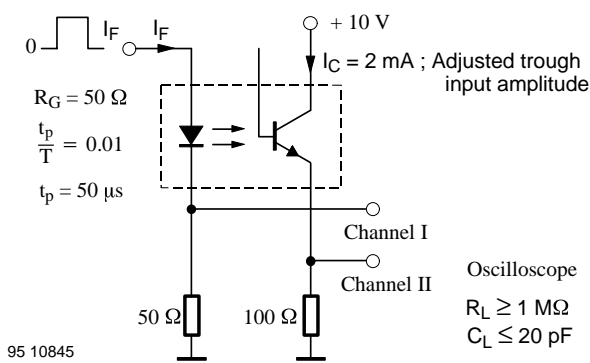


Figure 1. Test circuit, non-saturated operation

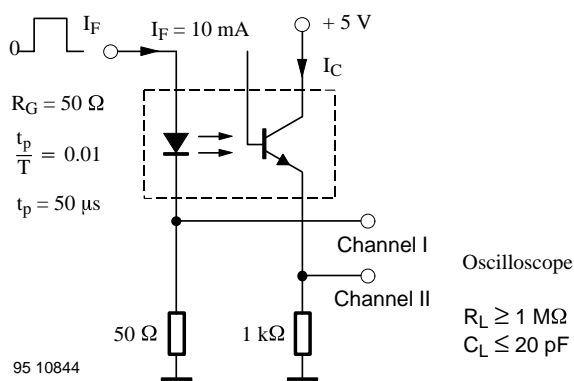


Figure 2. Test circuit, saturated operation

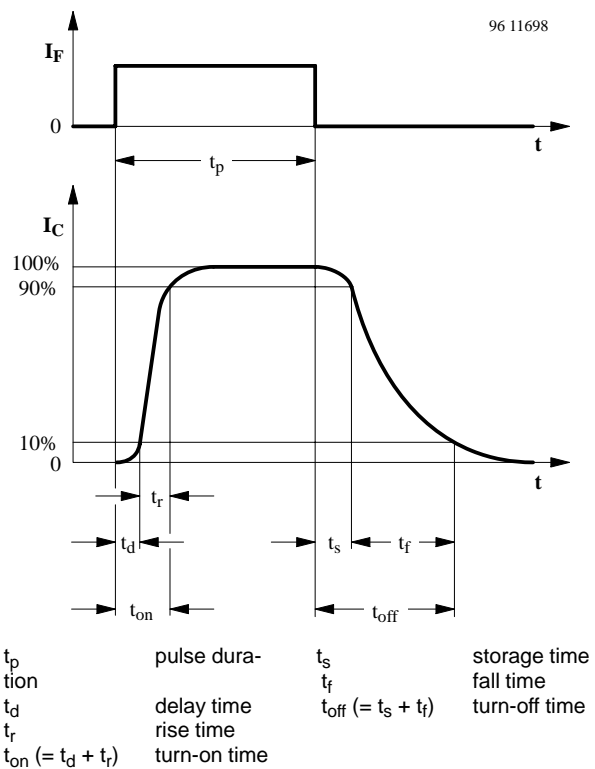


Figure 3. Switching times

### Typical Characteristics ( $T_{amb} = 25^{\circ}\text{C}$ , unless otherwise specified)

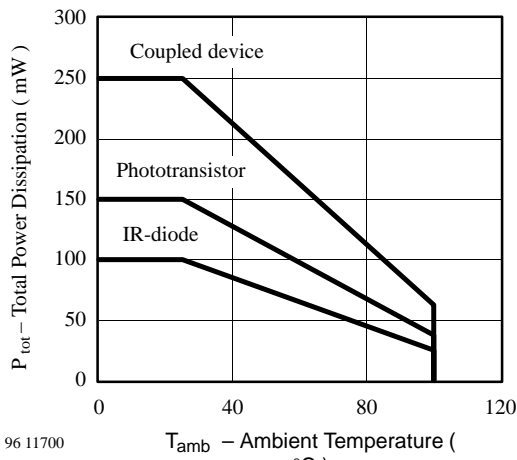


Figure 4. Total Power Dissipation vs. Ambient Temperature

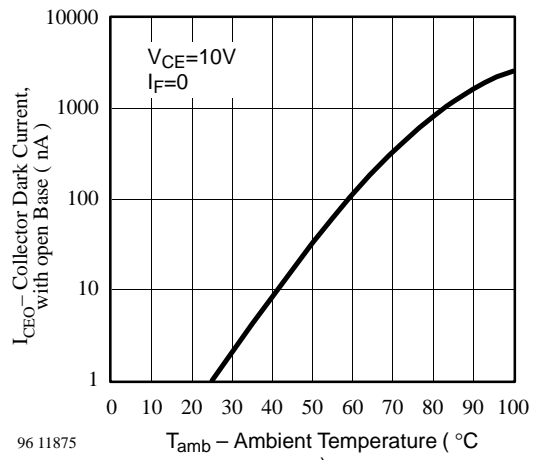


Figure 7. Collector Dark Current vs. Ambient Temperature

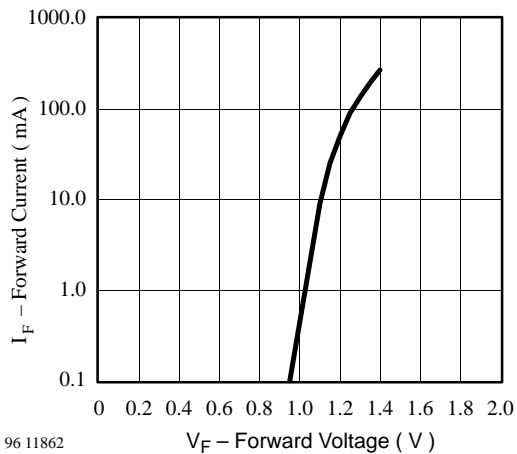


Figure 5. Forward Current vs. Forward Voltage

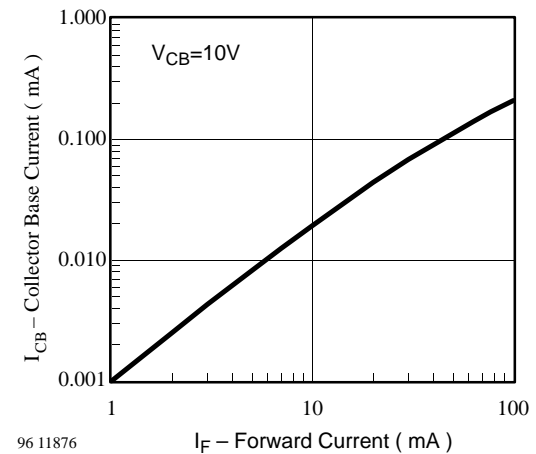


Figure 8. Collector Base Current vs. Forward Current

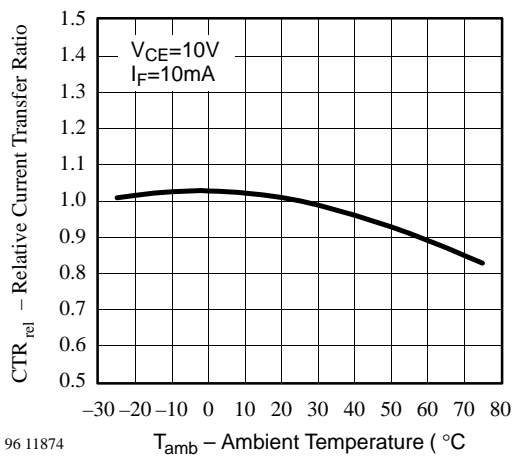


Figure 6. Relative Current Transfer Ratio vs. Ambient Temperature

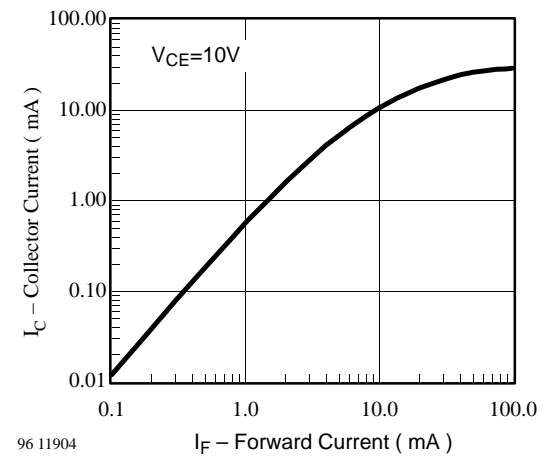


Figure 9. Collector Current vs. Forward Current

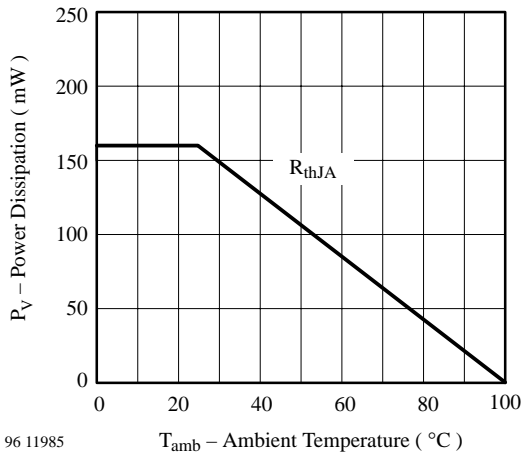


Figure 10. Collector Current vs. Collector Emitter Voltage

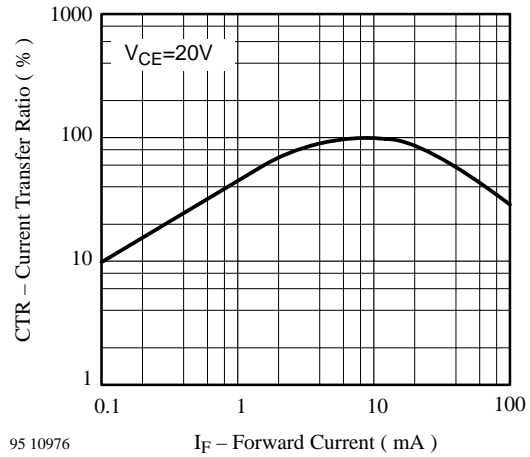


Figure 13. Current Transfer Ratio vs. Forward Current

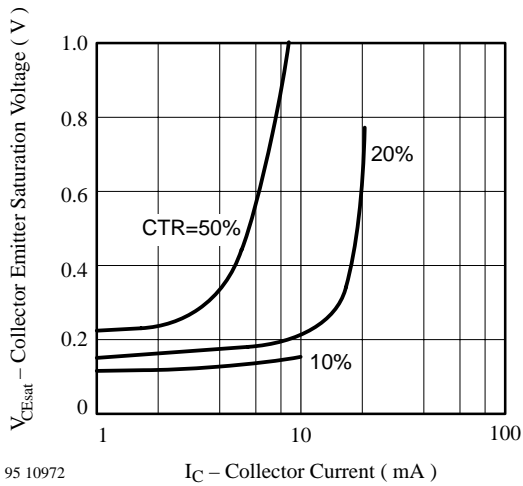


Figure 11. Collector Emitter Saturation Voltage vs. Collector Current

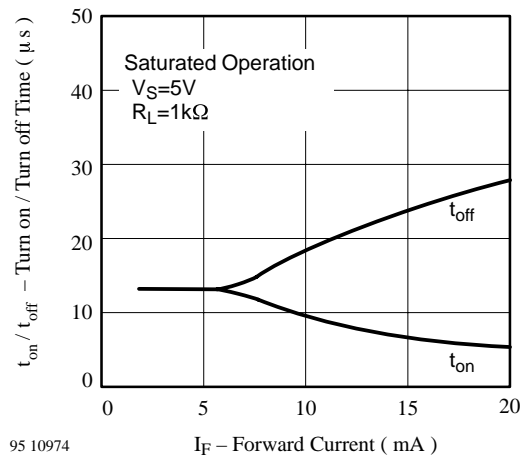


Figure 14. Turn on / off Time vs. Forward Current

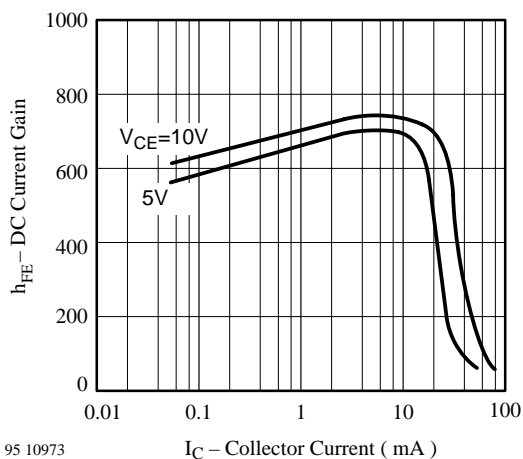


Figure 12. DC Current Gain vs. Collector Current

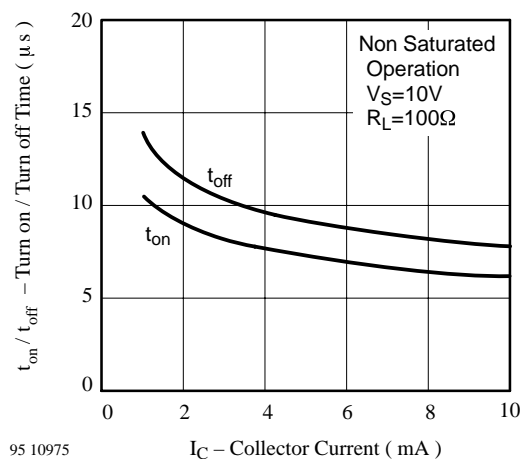


Figure 15. Turn on / off Time vs. Collector Current

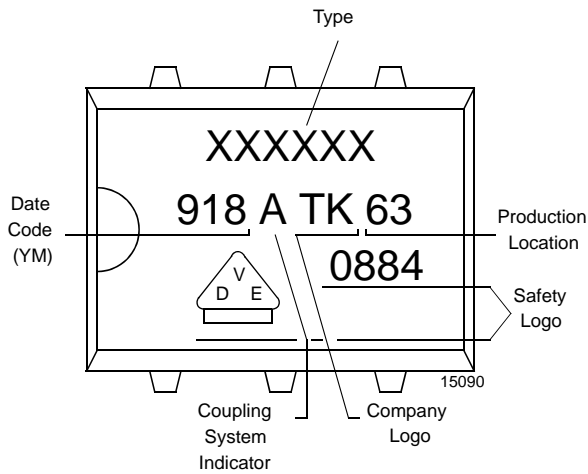
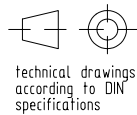
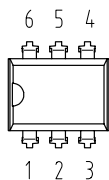
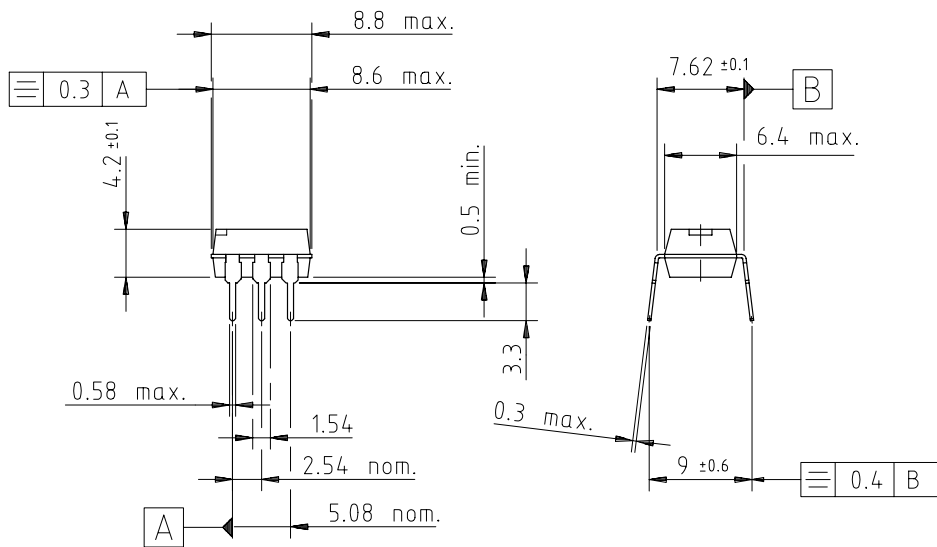


Figure 16. Marking example

### Dimensions of 4N3. in mm



weight: 0.50 g  
 creepage distance:  $\geq 6$  mm  
 air path:  $\geq 6$  mm

after mounting on PC board

14770